Brewer Science® WaferBOND® HT-10.10

Temporary Wafer Bonding Material

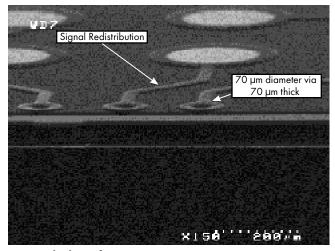


WaferBOND® HT-10.10 temporary bonding material enables back-end-of-line (BEOL) processing of ultrathin wafers with standard semiconductor equipment.

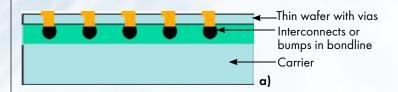
WaferBond® HT-10.10 material is an organic coating for hightemperature temporary wafer bonding for MEMS and 3-D waferlevel packaging applications. WaferBOND® HT-10.10 material enables thinning and backside standard lithographic processing through effective bonding and subsequent thermal debonding. The material has been developed and tested especially for use in through-silicon via creation, finishing, and redistribution layer completion in processes up to 220°C.

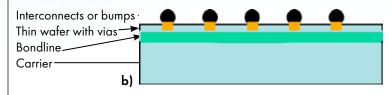
Benefits

- Process ultrathin wafers using standard BEOL technique and tooling
- Create interconnects before or after thinning
- Transfer completed thinned wafer to film frame for final testing and dicing



70-µm thick wafer, 1:1-aspect-ratio vias, copper redistribution layer





Solder bumps or posts may be a) captured in bond line before thinning or b) created after backside processing.



Thinned device may be mounted on film frame for dicing and pick-and-place handling.

Where innovation takes flight![™] Page 1

Processing

Coating Parameters (20 µm coating on 8-inch wafer)

Processes are available for 50 µm and 100 µm coating.

Spin Speed: 1000 to 2500 rpm Acceleration: 1000 rpm/s Spin Time: 30 to 60 s

Hot Plate Bake Process

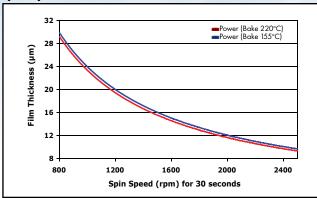
Proximity Bake:

 $180\,^{\circ}$ C at $3000\,\mu m$ for 1 minute $180\,^{\circ}$ C at $1500\,\mu m$ for 1 minute $180\,^{\circ}$ C at $500\,\mu m$ for 2 minutes

- or -

Contact Bake: 120°C for 2 minutes 180°C for 2 minutes

Spin Speed Curve



Bonding Process

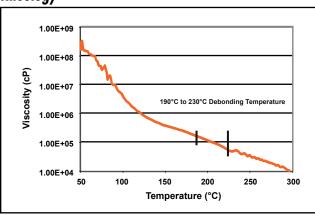
Temperature: 180°C Time: 2 minutes Vacuum: 5 mbar

Pressure: ~15.5 psi (flat wafers)

Mechanical Debonding Process

EVG® Debonder at 190°C to 220°C Fast slide-off debonding cycle (< 5 min)

Rheology



Thin Wafer Cleaning Process

Without MegPie Tool

- 1. Dispense WaferBOND Remover at 1 ml/s with wafer spinning at 900 rpm for 10 s
- 2. Spin off Remover at 900 rpm for 10 s
- 3. Repeat step 1 and 2 thirteen (13) times (total cycles = 14, total time = 280 s)
- 4. Rinse with IPA at center for 30 s at 900 rpm
- 5. Sweep rinse with isopropyl alcohol (IPA) for 30 s at 900 rpm
- 6. Spin dry at 2000 rpm for 30 s

With MegPie Tool*

- 1. Complete steps 1 through 3 above
- Cover the wafer surface with Remover and clean with MegPie for 3 minutes
- 3. Rinse with IPA at center for 30 s at 900 rpm
- 4. Sweep rinse with IPA for 30 s at 900 rpm
- 5. Spin dry at 2000 rpm for 30 s

*Care must be taken to insure that no backside contamination results from use of MegPie. With use of WaferBOND Remover, more data is needed to support use of MegPie as some studies suggest MegPie may increase particle counts.

Storage Conditions

Store at room temperature (16°C to 26°C)

Resistance to Process Chemicals

Chemical Resistance Testing with No Degradation

25°C	
23 C	25 min
85°C	60 min
60°C	30 min
60°C	40 min
25°C	30 min
25°C	20 min
25°C	5 min
25°C	5 min
25°C	5 min
25°C	5 min
25°C	5 min
25°C	5 min
25°C	5 min
25°C	90 min
25°C	60 min
	85°C 60°C 50°C 25°C 25°C 25°C 25°C 25°C 25°C 25°C 25

Note: An HMDS pretreatment is recomended for the following exposure recipe:

0.26N TMAH	60°C	30 min
30% KOH	85°C	60 min

Please contact your Brewer Science, Inc., representative for process recommendations for thicker coatings of 50 µm and 100 µm, or reach us through the Internet at www.brewerscience.com/contact-us.

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